



PRELIMINARY

C9914

Clock Generator for 100MHz and 133.3MHz Mobile Applications

Product Features

- Supports Intel 440BX, and VIA Promedia chipsets
- Supports mobile Pentium®II and Pentium®III
- 2 REF clocks
- 2 Low Skew (<175pS) CPU clocks
- 6 PCI Clocks (1 free running, 5 manageable)
- 1 48MHz fixed clock
- 1 selectable 48 or 24 MHz fixed clock
- Separate supply pins for mixed 3.3/2.5V application.
- High Speed host bus operation, up to 150MHz
- Cypress Spread Spectrum technology for reducing EMI
- Rich Power Management Functions.
- 28-pin SSOP & TSSOP packages for minimum board space.

Frequency Table(MHz)

HFS#	SEL 100/66#	CPU(1:2)	PCI(_F,1:5)
1	0	66.6	33.3
1	1	100	33.3
0	0	150	37.5
0	1	133.3	33.3

Table 1

Pin Configuration

VSS	1	28	VDDR
XIN	2	27	REF1/SEL48#
XOUT	3	26	REF2/SS#
PCI_F	4	25	VDDC
PCI1	5	24	CPU1
PCI2	6	23	CPU2
VSS	7	22	VSS
VDDP	8	21	VSS
PCI3	9	20	PS#
PCI4	10	19	VDD
PCI5	11	18	CS#
VDDF	12	17	PD#
48M	13	16	SEL100/66#
48_24/HFS#	14	15	VSS

Block Diagram

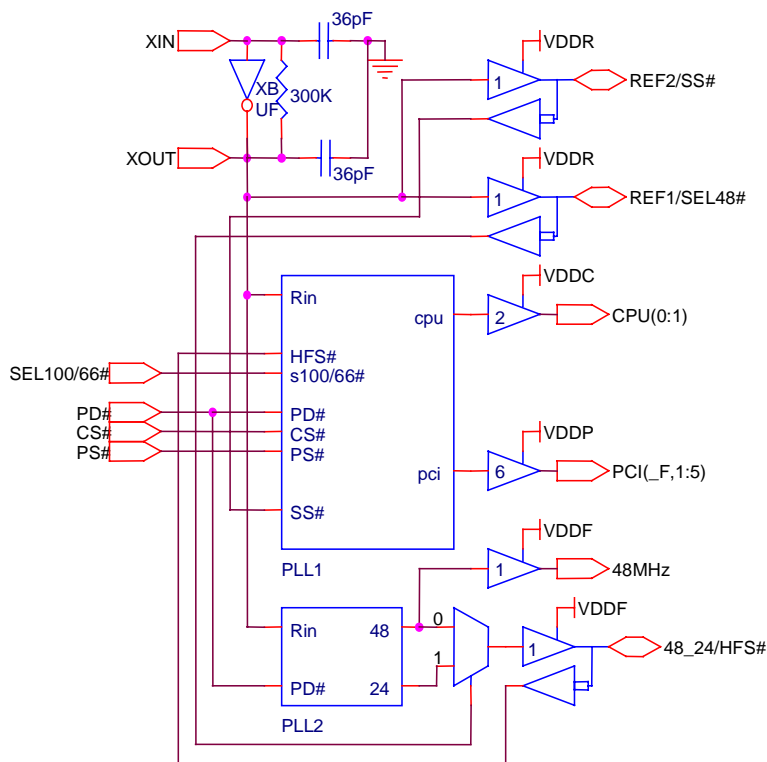


Fig.1



Clock Generator for 100MHz and 133.3MHz Mobile Applications

Pin Description

PIN No.	Pin Name	PWR	I/O	Description
2	XIN	VDD	I	On-chip reference oscillator input pin. Requires either an external parallel resonant crystal (nominally 14.318 MHz) or externally generated reference signal
3	XOUT	VDD	O	O-chip reference oscillator output pin. Drives an external parallel resonant crystal (14.318 MHz) when an externally generated reference signal is used.
19	VDD	-	P	3.3 volt power supply for core logic.
23, 24	CPU(2,1)	VDDC	O	CPU Clock outputs. See frequency table page 1.
17	PD#	-	I	Powers down device when LOW ⁽¹⁾
18	CS#	-	I	When signal is LOW, stops CPU clocks in low state. ⁽¹⁾
16	SEL100/66#	-	I	Frequency select input pins. See frequency select table 1 on page 1. NO INTERNAL PULLUP RESISTOR AT THIS INPUT.
25	VDDC	-	P	2.5V power for CPU and Host clock outputs.
4	PCI_F	VDDP	O	Free running PCI clock 3.3V. Does not stop when PS# is at a logic LOW level
5,6,9,10,11	PCI(1:5)	VDDP	O	PCI output clocks. See frequency table of page 1.
20	PS#	-	I	When signal is LOW, stops all PCI clocks in low state. ⁽¹⁾
8	VDDP	-	P	3.3 Volt power supply pins for free running PCI clock output buffer.
13	48M	VDDF	O	Fixed 48 MHz clock.
14	48-24MHZ / HFS#	VDDF	I/O	This is a Power up Bi-directional pin. During power up, this pin is an HFS# input. HFS# is a High Frequency Select line for programming the CPU/PCI output clock frequency, see table 1 page 1. For strapping resistor, see application note page 5. When the power reaches the rail, this pin becomes an SIO or USB clock output depending on the state of pin 27, SEL48#. If SEL48# is strapped high, then the frequency is 24MHz, SIO. If SEL48# is strapped low, then the frequency is 48MHz, USB. ⁽¹⁾
26	REF1 / SS#	VDDR	I/O	At power up this pin determines if the device's spread spectrum modulation feature is enabled or disabled. After power up this pin becomes a reference clock output. A 0 (logic low) enables SSCG and a 1 (logic high) disables SSCG. ⁽¹⁾
27	REF2 / SEL48#	VDDR	I/O	At power up this pin determine the frequency of the clock at pin 14. If it is LOW, the clock will be 48 MHz, if HIGH the clock will be 24 MHz. After power up this pin will become a reference clock output. (Default high)
12	VDDF	-	P	Power for fixed clock output buffer.
1,7,15,21,22	VSS	-	P	Ground pins for device.
28	VDDR	-	P	Power for Reference Oscillator output buffer.

Note:

1. Pins have internal pullup resistors that will guarantee to a logic 1 (high) level if no connection is made to the device's pin. Other pins do not contain this function and must be electrically connected to VDD or VSS by external circuitry to ensure a valid logic 1 or 0 is sensed.

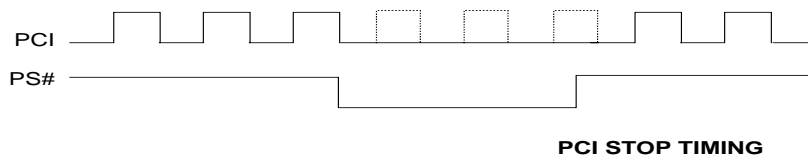
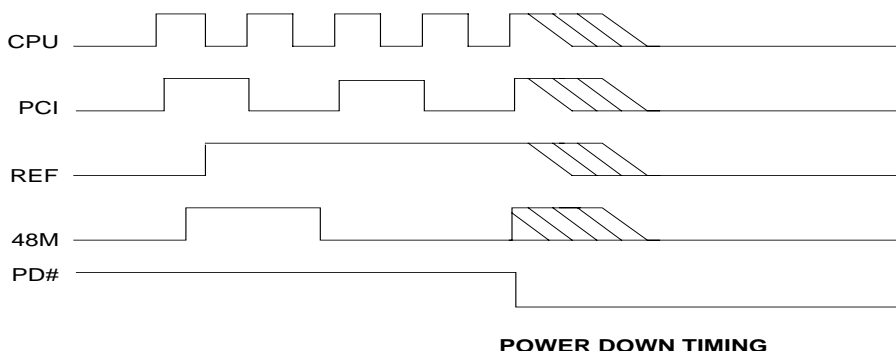
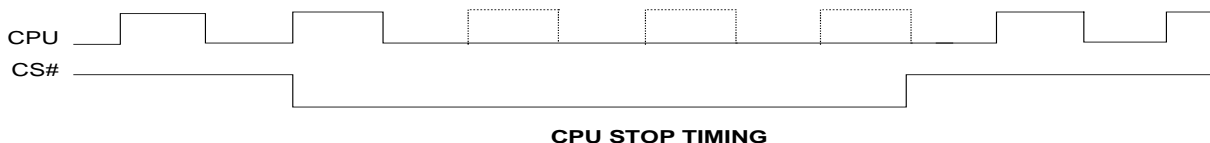


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Power Management Functions

PS#	CS#	PD#	CPU (1:2)	48M, 48_24M	PCI (1:5)	PCI_F	REF (1:2)	VCOs
X	X	0	LOW	LOW	LOW	LOW	LOW	OFF
1	0	1	LOW	ON	ON	ON	ON	ON
0	1	1	ON	ON	LOW	ON	ON	ON
0	0	1	LOW	ON	LOW	ON	ON	ON
1	1	1	ON	ON	ON	ON	ON	ON

CS# is the CPU stop control pin. It is used to turn off the CPU clocks for low power operation. CS# is asserted asynchronously by the external clock control logic with the rising edge of free running PCI clock (and hence CPU Clock) and must be internally synchronized to the external PCI_F output. All other clocks will continue to run while the CPU clocks are disabled. The CPU clocks will always be stopped in a low state and started in such a manner as to guarantee that the high pulse width is a full pulse. CPU clock on latency need to be **2 or 3 CPU clocks** periods in time and CPU clock off latency needs to be **2 or 3 CPU clocks** periods in time.





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Power Management Functions (Cont.)

The power down selection is used to put the part into a very low power state without turning off the power to the part. PD# is an asynchronous active low input. This signal needs to be synchronized internal to the device prior to powering down the clock synthesizer. PD# is an asynchronous function for powering up the system. Internal clocks are not running after the device is put in power down. When PD# is active low, all clocks need to be driven to a low value and held prior to turning off the VCO's and the Crystal. The power-up latency needs to be less than 3 mS. The power down latency should be as short as possible but conforming to the sequence requirements shown below. AS# and CS# are considered to be don't cares during the power down operations.

Power Management Timing

Signal	Signal State	Latency
		No. of rising edges of free running PCI CLOCK (PCIF)
CS#	0 (disabled)	1
	1 (enabled)	1
PD#	1 (cold start/normal operation)	3 mS
	0 (power down)	1

NOTES: Clock on/off latency is defined in the number of rising edges of free running PCI CLOCK between the clock disable goes low/high to the first valid clock comes out of the device.

Power on Bi-Directional Pins

Power Up Condition:

Pins 14, 26, and 27 are Power up bi-directional pins and are used for different features in this device (see Pin description, Page 2). During power-up, these pins are in input mode (see Fig 2, below), therefore, they are considered input select pins internal to the IC. After a settling time, the Selection data is latch into internal control registers and these pins become toggling clock outputs.

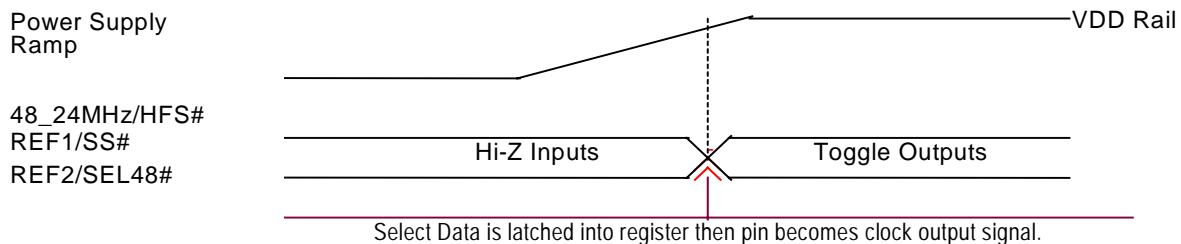


Fig. 2

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Strapping Resistor Options for pins with internal Pull-ups:

The power up bidirectional pins have a large value pull-up each (250K Ω), therefore, a selection "1" is the default. If the system uses a slow power supply (over 3mS settling time), then **it is recommended** to use an external Pullup (Rup) in order to insure a high selection. In this case, the designer may choose one of two configurations, see Fig. 3A and Fig. 3B.

Fig. 3A represents an additional pull up resistor 50K Ω connected from the pin to the power line, which allows a faster pull to a high level.

If a selection "0" is desired, then a jumper is placed on JP1 to a 5K Ω resistor as implemented as shown in Fig.3A. Please note the selection resistors (Rup, and Rdn) are placed before the Damping resistor (Rd) close to the pin.

Fig. 3B represent a single resistor 10K Ω connected to a 3 way jumper, JP2. When a "1" selection is desired, a jumper is placed between leads1 and 3. When a "0" selection is desired, a jumper is placed between leads 1 and 2.

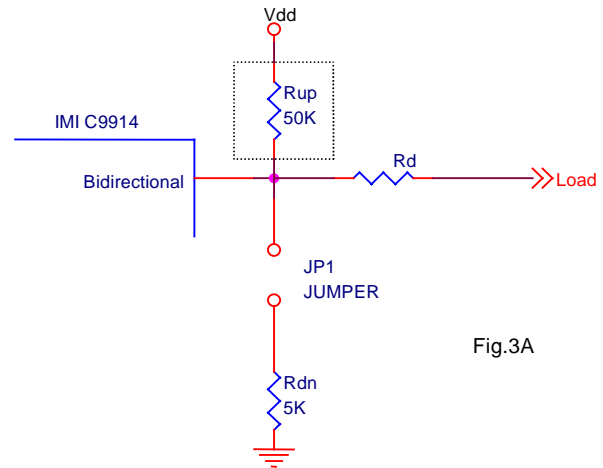


Fig.3A

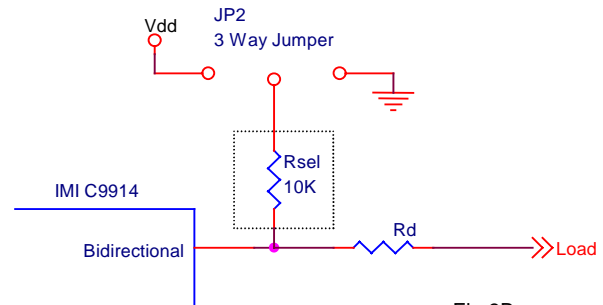
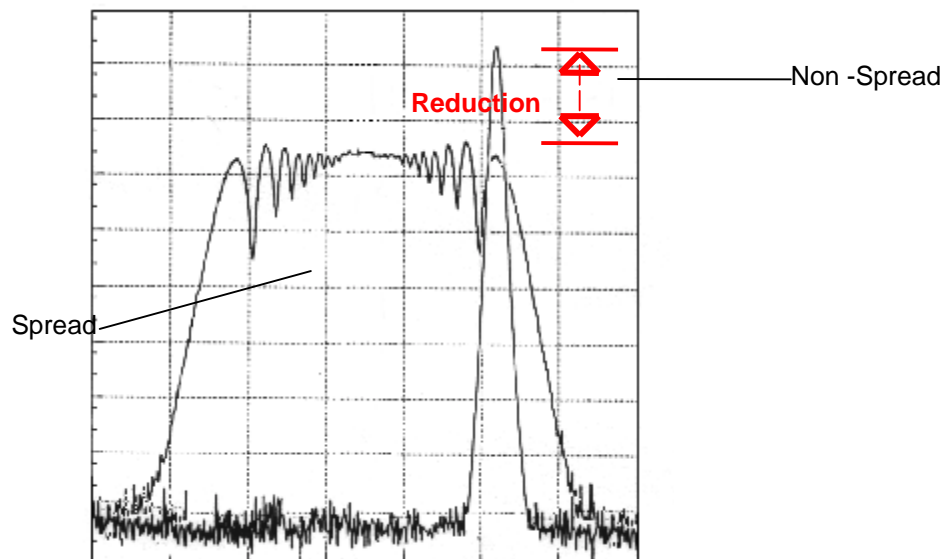


Fig.3B

Spectrum Spread Clocking

Spectrum Analysis



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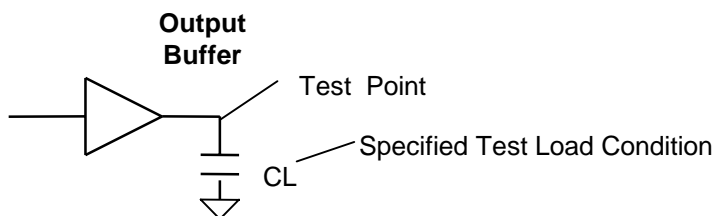
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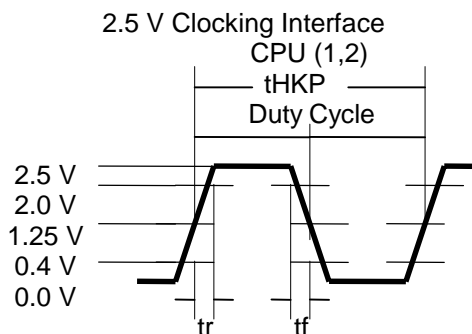
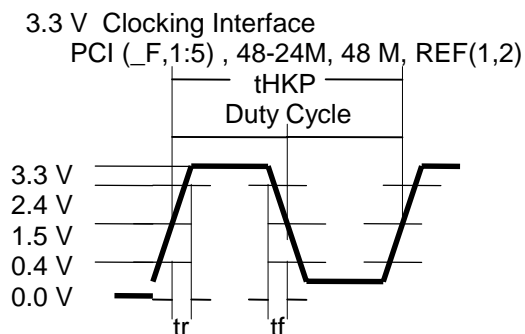
Spectrum Spreading Selection Table

Min (MHz)	Center (MHz)	Max (MHz)	CPU Frequency	% OF FREQUENCY SPREADING	MODE
99.3	99.65	100	100	.7% (-.7% + 0%)	Down Spread
66.13	66.37	66.6	66	.7% (-.7% + 0%)	Down Spread
132.4	132.87	133.33	133.3	.7% (-.7% + 0%)	Down Spread
148.95	149.48	150	150	.7% (-.7% + 0%)	Down Spread

Test and Measurement Condition



Clock Output Wave Form



**Clock Generator for 100MHz and 133.3MHz Mobile Applications****Absolute Maximum Ratings**

Maximum Input Voltage Relative to VSS: VSS - 0.3V
Maximum Input Voltage Relative to VDD: VDD + 0.3V
Storage Temperature: -65°C to + 150°C
Operating Temperature: 0°C to +85°C
Maximum ESD protection 2KV
Maximum Power Supply: 5.5V

This device contains circuitry to protect the inputs against damage due to high static voltages or electric field; however, precautions should be taken to avoid application of any voltage higher than the maximum rated voltages to this circuit. For proper operation, Vin and Vout should be constrained to the range:

$$VSS < (V_{in} \text{ or } V_{out}) < VDD$$

Unused inputs must always be tied to an appropriate logic voltage level (either VSS or VDD).

DC Electrical Characteristics

Characteristic	Symbol	Min	Typ	Max	Units	Conditions
Input Low Voltage	VIL	-	-	0.8	Vdc	
Input High Voltage	VIH	2.0	-	-	Vdc	
Input Low Current	IIL			-66	μA	
Input High Current	IIH			5	μA	
Output Low Voltage IOL = 4mA	VOL	-	-	0.4	Vdc	All Outputs (see buffer spec)
Output High Voltage IOH = 4mA	VOH	2.4	-	-	Vdc	All Outputs Using 3.3V Power (see buffer spec)
Dynamic Supply Current	Idd2 ₆₆	-	-	70	mA	CPU = 66.6M
(2.5 Volt Supply)	Idd2 ₆₆	-	-	40	mA	CPU = 66.6M
Dynamic Supply Current	Idd3 ₁₀₀	-	-	70	mA	CPU = 100M
(3.3 Volt Supply)	Idd3 ₁₀₀	-	-	50	mA	CPU = 100M
Power Down Mode	I2.5 _{PD}	-	-	50	μA	PD# at logic low level
Power Down Mode	I3.3 _{PD}	-	-	4.5	mA	PD# at logic low level
VDD = VDDF = VDDP = VDDR = 3.3V ±5%, VDDC = 2.5V ±5%, TA = 0°C to +70°C						

**Clock Generator for 100MHz and 133.3MHz Mobile Applications****AC Switching Characteristics**

Characteristic	Symbol	Min	Typ	Max	Units	Conditions
Output Duty Cycle	-	45	50	55	%	CPU= Measured at 1.25V all others measured at 1.50V
CPU to PCI Offset (CPU leads)	tOFF	1.5	-	4	ns	CPU=20 pF load Measured at 1.25V PCI=30 pF load Measure at 1.50V
ΔPeriod Adjacent Cycles	ΔP	-	-	±500	pS	PCI Only
VDD = VDDF = VDDP = VDDR = 3.3V ±5%, VDDC = 2.5V ±5%, TA = 0°C to +70°C						

AC Skew Requirements

Characteristic	Bank Skew	Cycle to Cycle Jitters	VDD	Skew, Jitters Measure Point
CPU (20pF)	175pS	250pS	2.5V	1.25V
48 MHz	n/a	500pS	3.3V	1.5V
PCI, PCI_F (30pF)	500pS	500pS	3.3V	1.5V
REF	n/a	500pS	3.3V	1.5V

Buffer Characteristics**Buffer Characteristics for CPU Outputs**

Characteristic	Symbol	Min	Typ	Max	Units	Conditions
Pull-Up Current Min	IOH _{min}	-27	-		mA	Vout = 1.0 V
Pull-Up Current Max	IOH _{max}			-27	mA	Vout = 2.375 V
Pull-Down Current Min	IOL _{min}	27	-	-	mA	Vout = 1.2 V
Pull-Down Current Max	IOL _{max}	-	-	30	mA	Vout = 0.3 V
Rise Time Between 0.4 V and 2.0 V	TR	0.4	-	1.6	nS	20 pF Load
Fall Time Between 0.4 V and 2.0 V	TF	0.5	-	1.6	nS	20 pF Load
VDD = VDDF = VDDP = VDDR = 3.3V ±5%, VDDC = 2.5V ±5%, TA = 0°C to +70°C						



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Buffer Characteristics for 48M, 48-24M and REF Outputs

Characteristic	Symbol	Min	Typ	Max	Units	Conditions
Pull-Up Current Min	IOH_{min}	-29	-	-	mA	$V_{out} = 1.0\text{ V}$
Pull-Up Current Max	IOH_{max}	-	-	-63	mA	$V_{out} = 3.135\text{ V}$
Pull-Down Current Min	IOL_{min}	20	-	-	mA	$V_{out} = 1.95\text{ V}$
Pull-Down Current Max	IOL_{max}	-	-	27	mA	$V_{out} = 0.4\text{ V}$
Rise Time Between 0.4 V and 2.4 V	TR	0.5	-	2.0	nS	20 pF Load
Fall Time Between 0.4 V and 2.4 V	TF	0.5	-	2.0	nS	20 pF Load

DC Buffer Characteristics for PCI_F, PCI (1:5)

Characteristic	Symbol	Min	Typ	Max	Units	Conditions
Pull-Up Current Min	IOH_{min}	-33	-	-	mA	$V_{out} = 1.0\text{ V}$
Pull-Up Current Max	IOH_{max}	-	-	-100	mA	$V_{out} = 3.135\text{ V}$
Pull-Down Current Min	IOL_{min}	20	-	-	mA	$V_{out} = 1.95\text{ V}$
Pull-Down Current Max	IOL_{max}	-	-	38	mA	$V_{out} = 0.4\text{ V}$
Rise Time Between 0.4 V and 2.4 V	TR	0.5	-	2.0	nS	30 pF Load
Fall Time Between 0.4 V and 2.4 V	TF	0.5	-	2.0	nS	30 pF Load
$VDDP = VDDR = 3.3V \pm 5\%$, $VDDC = 2.5V \pm 5\%$, $TA = 0^{\circ}C$ to $+70^{\circ}C$						



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Suggested Oscillator Crystal Parameters

Characteristic	Symbol	Min	Typ	Max	Units	Conditions
Frequency	F _o	14.17	14.31818	14.46	MHz	
Tolerance	T _C	-	-	+/-100	PPM	Note 1
Frequency Stability	T _S	-	-	+/- 100	PPM	Stability (T _A -10 to +60C) Note 1
Operating Mode	-	-	-	-		Parallel Resonant, Note 1
Load Capacitance	C _{XTAL}	-	20	-	pF	The crystal's rated load. Note 1
Effective Series Resistance (ESR)	R _{ESR}	-	40	-	Ohms	Note 2

Note1: For best performance and accurate frequencies from this device, It is recommended but not mandatory that the chosen crystal meets or exceeds these specifications

Note 2: Larger values may cause this device to exhibit oscillator startup problems

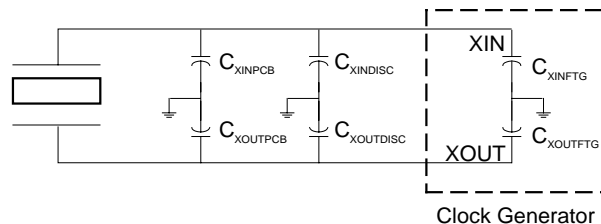
To obtain the maximum accuracy, the total circuit loading capacitance should be equal to C_{XTAL}. This loading capacitance is the effective capacitance across the crystal pins and includes the clock generating device pin capacitance (C_{FTG}), any circuit trace capacitance (C_{PCB}), and any onboard discrete load capacitance (C_{DISC}).

The following formula and schematic illustrates the application of the loading specification of a crystal (C_{XTAL})for a design.

$$C_L = \frac{(C_{XINPCB} + C_{XINFTG} + C_{XINDISC}) \times (C_{XOUTPCB} + C_{XOUTFTG} + C_{XOUTDISC})}{(C_{XINPCB} + C_{XINFTG} + C_{XINDISC}) + (C_{XOUTPCB} + C_{XOUTFTG} + C_{XOUTDISC})}$$

Where:

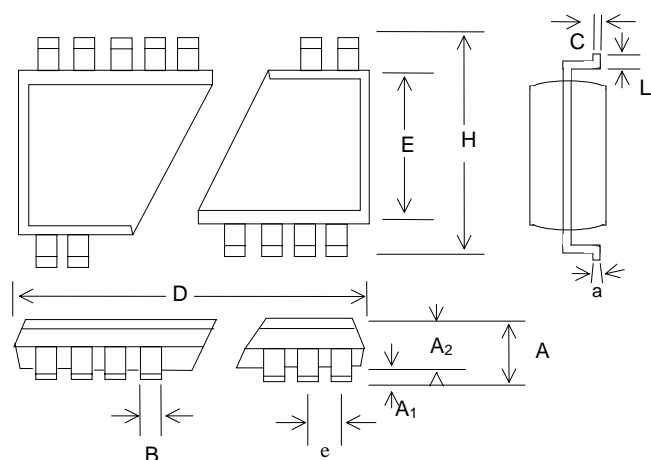
- C_{XTAL} = the load rating of the crystal
- C_{XOUTFTG} = the clock generators XOUT pin effective device internal capacitance to ground
- C_{XOUTPCB} = the clock generators XOUT pin effective device internal capacitance to ground
- C_{XINPCB} = the effective capacitance to ground of the crystal to device PCB trace
- C_{XOUTPCB} = the effective capacitance to ground of the crystal to device PCB trace
- C_{XINDISC} = any discrete capacitance that is placed between the XIN pin and ground
- C_{XOUTDISC} = any discrete capacitance that is placed between the XOUT pin and ground



As an example, and using this formula for this datasheet's device, a design that has no discrete loading capacitors (C_{DISC}) and each of the crystal to device PCB traces has a capacitance (C_{PCB}) to ground of 4pF (typical value) would calculate as:

$$C_L = \frac{(4pF + 36pF + 0pF) \times (4pF + 36pF + 0pF)}{(4pF + 36pF + 0pF) + (4pF + 36pF + 0pF)} = \frac{40 \times 40}{40 + 40} = \frac{1600}{80} = 20pF$$

Therefore to obtain output frequencies that are as close to this data sheets specified values as possible, in this design example, you should specify a parallel cut crystal that is designed to work into a load of 20pF

Package Drawings and Dimensions

28 Pin SSOP Outline Dimensions

SYMBOL	INCHES			MILLIMETERS		
	MIN	NOM	MAX	MIN	NOM	MAX
A	0.068	0.073	0.078	1.73	1.86	1.99
A ₁	0.002	0.005	0.008	0.05	0.13	0.21
A ₂	0.066	0.068	0.070	1.68	1.73	1.78
B	0.010	0.012	0.015	0.25	0.30	0.38
C	0.005	0.006	0.009	0.13	0.15	0.22
D	0.397	0.402	0.407	10.07	10.20	10.33
E	0.205	0.209	0.212	5.20	5.30	5.38
e	0.025 BSC			0.635 BSC		
H	0.301	0.307	0.311	7.65	7.80	7.90
a	0°	4°	8°	0°	4°	8°
L	0.022	0.030	0.037	0.55	0.75	0.95

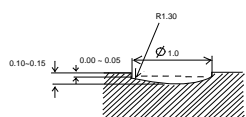
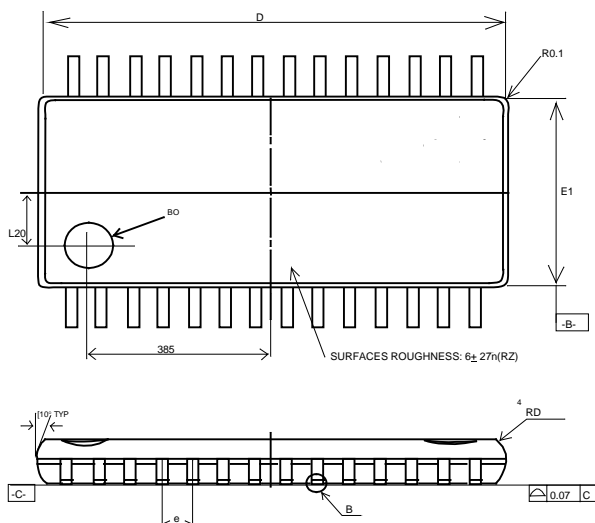


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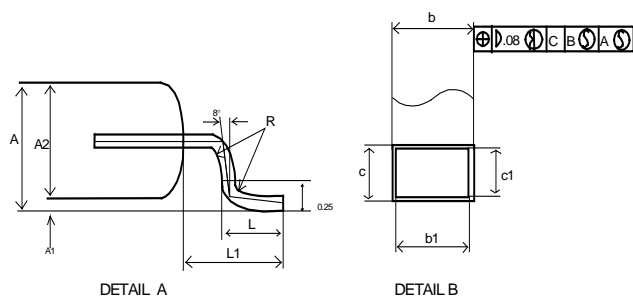
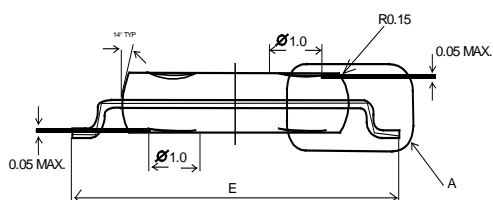
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Package Drawings and Dimensions



SECTION V-V



28 Pin TSSOP Dimensions

SYMBOL	INCHES			MILLIMETERS		
	MIN	NOM	MAX	MIN	NOM	MAX
A	-	-	0.047	-	-	1.20
A1	0.002	0.004	0.006	0.05	0.10	0.15
A2	0.037	0.039	0.041	0.95	1.00	1.05
L	0.019	0.023	0.029	0.50	0.60	0.75
L1	0.035	0.039	0.043	0.90	1.00	1.10
b	0.007	-	0.011	0.19	-	0.30
b1	0.007	0.008	0.010	0.19	0.22	0.25
c	0.004	-	0.007	0.105	-	0.175
c1	0.004	0.005	0.006	0.105	0.125	0.145
θ	0°	-	8°	0°	-	8°
e	0.026 BSC			0.65 BSC		
D	0.378	0.382	0.386	9.6	9.7	9.8
E	0.244	0.252	0.260	6.2	6.4	6.6
E1	0.169	0.173	0.177	4.3	4.4	4.5
R	0.035	-	-	0.9	-	-



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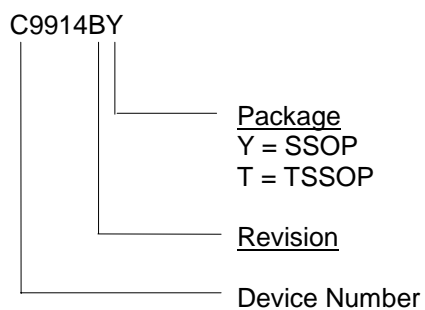
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Ordering Information

Part Number	Package Type	Production Flow
C9914BY	28 PIN SSOP	Commercial, 0°C to + 85°C
C9914BT	28 PIN TSSOP	Commercial, 0°C to + 85°C

Note: The ordering part number is formed by a combination of device number, device revision, package style, and screening as shown below.

Marking: Example: Cypress
C9914
Date Code, Lot #



Notice

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Document Title: C9914 Clock Generator for 100 MHz and 133.3 MHz Mobile Applications				
Document Number: 38-07069				
Rev.	ECN No.	Issue Date	Orig. of Change	Description of Change
**	107105	06/07/01	IKA	Convert from IMI to Cypress